

Subject card

Subject name and code	Physical methods of materials testing , PG_00058939								
Field of study	Nanotechnology								
Date of commencement of studies	October 2022		Academic year of realisation of subject			2023/2024			
Education level	first-cycle studies		Subject group			Obligatory subject group in the field of study			
							Subject group related to scientific research in the field of study		
Mode of study	Full-time studies		Mode of delivery			at the university			
Year of study	2		Language of instruction			Polish			
Semester of study	4		ECTS credits			2.0			
Learning profile	general academic profile		Assessment form			assessment			
Conducting unit	Institute of Nanotechr	erials Enginee	ring -> Faculty	of Appli	ied Physics and Mathematics				
Name and surname	Subject supervisor	dr hab. inż. Marcin Łapiński							
of lecturer (lecturers)	Teachers		dr hab. inż. Marcin Łapiński						
Lesson types and methods of instruction	Lesson type	Lecture	Tutorial	Laboratory	Projec	:t	Seminar	SUM	
	Number of study hours	30.0	0.0 0.0 0.0		0.0		0.0	30	
	E-learning hours inclu	uded: 0.0							
Learning activity and number of study hours	Learning activity	Participation in classes include plan			Self-study S		SUM		
	Number of study hours			2.0		18.0		50	
Subject objectives	The aim of the course is to present the possibilities of modern measurement techniques, along with a description of appropriate measurement systems, methods of analyzing the results leading to the determination of structure parameters (macro-, micro- and nanoscopic, as well as at the atomic level) of the tested materials, determining the chemical composition and physical properties chemical and thermal.								
Learning outcomes	nes Course outcome		Subject outcome			Method of verification			
	K6_W10		The student is able to analyze the research problem, select a research method and plan a physical experiment to solve the problem. Is aware of the limitations related to the use of specific experimental methods.			[SW1] Assessment of factual knowledge			
	K6_W07		The student acquires extensive knowledge of methods for analyzing the physical properties of materials and nanomaterials. He learns both the theoretical foundations (in terms of the main phenomena, laws and relationships) as well as the technical and application aspects of the research methods discussed.			[SW1] Assessment of factual knowledge			
	K6_U02		The student has extended theoretical knowledge of research methods and techniques used in nanotechnology and materials engineering. Is able to select an appropriate experimental method to solve a given research problem.			[SU3] Assessment of ability to use knowledge gained from the subject [SU2] Assessment of ability to analyse information			

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Subject contents	1. Introduction; 2. Diffraction methods - theoretical basis: - X-ray diffraction; - Neutron diffraction; - Electron diffraction. 3. EM radiation sources; 4. Detectors of ionizing radiation; 5. Synchrotron, synchrotron radiation and its application. 6. Spectroscopic methods - introduction and theoretical basis: - Molecular spectroscopy (microwave, IR, Raman, UV-Vis); - Photoelectron spectroscopy (PES) and Auger electron spectroscopy (AES); - X-ray absorption spectroscopy (XAS). 7. Structure imaging methods: - Electron microscopy (SEM, TEM, STEM); - Scaning probe microscopy (STM, AFM); - Confocal microscopy. 6. Thermal analysis (DTA, DSC, TGA). 7. Methods of testing material porosity (mercury porosimetry, gas porosimetry, micro-CT) Prerequisites and co-requisites The basics knowledge of physics, crystallography, general chemistry and materials engineering						
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Assessment methods	Subject passing criteria	Passing threshold	Percentage of the final grade				
and criteria	writting exam	51.0%	100.0%				
Recommended reading	Supplementary literature Supplementary literature		1] A. Oleś, Metody doświadczalne fizyki ciała stałego, WNT (in polish) [2] J.Przedmojski, Rentgenowskie metody badawcze w Inżynierii Materiałowej, WNT (in polish) [3a] J. Sadlej, Spektroskopia molekularna, WNT, Warszawa (in polish) [3b] Z. Kęcki, Podstawy spektroskopii molekularnej, PWN, Warszawa (in polish) [4] A. Kisiel, Synchrotron jako narzędzie: zastosowanie PS w spektroskopii ciała stałego, SRNS 5(3) (2006) (in polish) [5] Ch. Kittel, P. McEuen, Introduction to solid state physics (9th Ed.), New Jersey: Wiley [6a] W. Moebs, S.J. Ling, J.S. Sanny, University Physics, OpenStax, Volume 2 [6b] W. Moebs, S.J. Ling, J.S. Sanny, University Physics, OpenStax, Volume 3 [7] J.M. Hollas, Modern Spectroscopy, John Wiley & Sons, Ltd. [8] P. Willmott, An Introduction to Synchrotron Radiation: Techniques and Applications, John Wiley & Sons, Ltd. [9] A. Barbacki (red.), Mikroskopia elektronowa, Wyd. Politechniki Poznańskiej (in polish) [10] P. Atkins, J.de Paula, Chemia fizyczna, Rozdz.16 Spektroskopia 1: widma rotacyjne i oscylacyjne; Rozdz. 17 Spektroskopia 2: przejścia elektronowe, PWN (in polish)				
	eResources addresses	Adresy na platformie eNauczanie: Fizyczne Metody Badań Materiałów - Moodle ID: 37956 https://enauczanie.pg.edu.pl/moodle/course/view.php?id=37956					
Example issues/ example questions/ tasks being completed	1. List and briefly characterize detectors of ionizing radiation. 2. Silicon crystallizes in a simple cubic system. A neutron diffraction experiment with a 10-meter detector and angle = 450 reveals that the neutrons reflected from the family of planes (111) have a time of flight of 11200 microseconds. Find the lattice constant of a silicon unit cell? 3. What is a synchrotron and how does it work? Describe the basic properties of synchrotron radiation. 4. What is a spectrum? Give and discuss the parameters that characterize the spectral line. 5. Explain the terms transmittance, absorbance and absorption coefficient. Give the relationship between them. 6. Present the idea of the Raman phenomenon and discuss the shape of the Raman spectrum. 7. Explain why the XPS technique is a "surface sensitive" technique. 8. Electron microscopy - list the types of electron microscopes, compare them and define the scope of applications. 9. Determine what thermal analysis is and what the types are. 10. Discuss the differences between physical and chemical adsorption.						
Work placement	Not applicable						

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